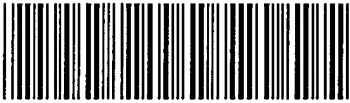
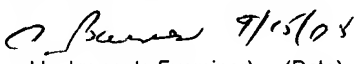


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/790,750		CHO ET AL.	
	Examiner		Art Unit	
	Sean P. Shechtman		2125	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
700		188			700	29	46	52		
INTERNATIONAL CLASSIFICATION					703	2				
G	0	6	F	19/00						
G	0	5	B	13/02						
G	0	6	F	17/10						
				/						
				/						

Sean Shechtman 8/12/05 (Assistant Examiner) (Date)		LEO PICARD SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) (Date)		Total Claims Allowed: 13	
 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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